Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination	
10517537	VAN BEEK ET AL.	
Examiner	Art Unit	
Tran, Nguyen	2838	

SEARCHED						
Class	Subclass	Date	Examiner			
320	128,160,137,139,129,130	1/24/2007	Nguyen Tran			

SEARCH NOTES					
Search Notes	Date	Examiner			
See East Search History	1/24/2007	Nguyen Tran			
Consulted with Fantu Yalkew for field of search	1/24/2007	Nguyen Tran			

INTERFERENCE SEARCH					
Class	Subclass	Date	Examiner		